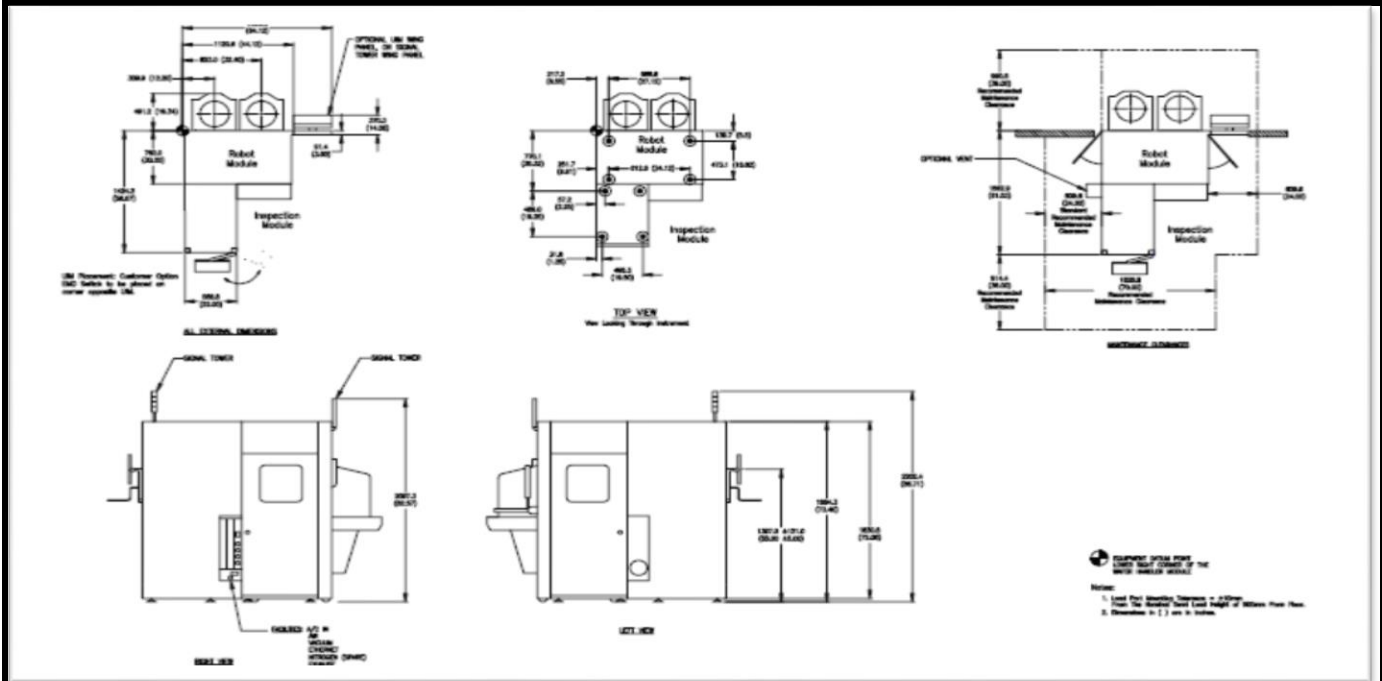


Process:	MACRO DEFECT INSPECTION
Equipment ID	AP-PMD-54
Model	WV320



Item	Detail
Loadports	2 Loadport with FOUP capable (Brooks)
Loadports Carrier Reader	RFID type
Robot	Yaskawa
Light source	20um head, high-intensity Xenon flash lamps to provide brightfield and darkfield wafer illumination, Wavelength range: 480-750nm
Resolution	above 25um
Function	YVS SERVER X1 by group 3D defect image generation ADC Function (Auto Defect Classification)
Component	Main model

